

# SLOVENSKI STANDARD SIST EN IEC 62153-4-15:2021/oprA1:2023

01-april-2023

# Preskusne metode za kovinske kable in druge pasivne komponente - 4-15. del: Elektromagnetna združljivost (EMC) - Preskusna metoda za meritve prenosne impedance in zaslonskega slabljenja ali sklopnega slabljenja s triosno celico -Dopolnilo A1

Metallic cables and other passive components test methods - Part 4-15: Electromagnetic compatibility (EMC) - Test method for measuring transfer impedance and screening attenuation - or coupling attenuation with triaxial cell

Prüfverfahren für metallische Kommunikationskabel - Teil 4-15: Elektromagnetische Verträglichkeit (EMV) - Prüfverfahren zur Messung des Kopplungswiderstandes und der Schirmdämpfung oder der Kopplungsdämpfung mit der Triaxialen Zelle

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Méthodes d'essais des câbles métalliques et autres composants passifs - Partie 4-15 : Compatibilité électromagnétique (CEM) - Méthode d'essai pour le mesurage de l'impédance de transfert et de l'affaiblissement d'écran - ou de l'affaiblissement de couplage avec cellule triaxiale

# Ta slovenski standard je istoveten z: EN IEC 62153-4-15:2021/prA1:2023

# ICS:

33.100.01	Elektromagnetna združljivost	Electromagnetic compatibility
	na splošno	in general
33.120.10	Koaksialni kabli. Valovodi	Coaxial cables. Waveguides

SIST EN IEC 62153-4-15:2021/oprA1:2023 en

2003-01. Slovenski inštitut za standardizacijo. Razmnoževanje celote ali delov tega standarda ni dovoljeno.

SIST EN IEC 62153-4-15:2021/oprA1:2023

# iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST EN IEC 62153-4-15:2021/oprA1:2023</u> https://standards.iteh.ai/catalog/standards/sist/632a9a65-40a8-4b4f-8060b9a401c672ce/sist-en-iec-62153-4-15-2021-opra1-2023



# 46/924/CDV

### COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:		
IEC 62153-4-15/AMD1 ED2		
DATE OF CIRCULATION:	CLOSING DATE FOR VOTING:	
2023-01-27	2023-04-21	
SUPERSEDES DOCUMENTS:		
46/919/RR		

C TC 46 : CABLES, WIRES, WAVEGUIDES, RF CONNECTORS, RF AND MICROWAVE PASSIVE COMPONENTS AND ACCESSORIES		
SECRETARIAT:	SECRETARY:	
United States of America	Mr David Wilson	
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:	
SC 46A,SC 46C,SC 46F,TC 48,SC 48B		
	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.	
FUNCTIONS CONCERNED: TAL STANDADD DDDDV/ICV/		
	QUALITY ASSURANCE SAFETY	
SUBMITTED FOR CENELEC PARALLEL VOTING	NOT SUBMITTED FOR CENELEC PARALLEL VOTING	
Attention IEC-CENELEC parallel voting		
The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting.	<u>-15:2021/oprA1:2023</u> ards/sist/632a9a65-40a8-4b4f-8060- .153-4-15-2021-opra1-2023	
The CENELEC members are invited to vote through the		

This document is still under study and subject to change. It should not be used for reference purposes.

Recipients of this document are invited to submit, with their comments, notification of

- any relevant patent rights of which they are aware and to provide supporting documentation,
- any relevant "in some countries" clauses to be included should this proposal proceed. Recipients are reminded that the enquiry stage is the final stage for submitting "in some countries" clauses. See AC/22/2007.

#### TITLE:

Amendment 1 - Metallic cables and other passive components test methods - Part 4-15: Electromagnetic compatibility (EMC) - Test method for measuring transfer impedance and screening attenuation - or coupling attenuation with triaxial cell

PROPOSED STABILITY DATE: 2029

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NOTE FROM TC/SC OFFICERS:

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#### IEC CDV 62153-4-15 A1 © IEC 2022

#### FOREWORD

This amendment has been prepared by IEC Technical committee 46: Cables, wires, waveguides, RF connectors, RF and microwave passive components and accessories.

The text of this amendment is based on the following documents:

FDIS	Report of voting
46/XX/FDIS	46/XX/RVD

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this amendment and the base publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.



#### Introductory note:

The goal of this amendment is: EN IEC 62153-4-15:2021/oprA1:2023

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- to extend the clause 10.3, expression of results by a conversion formula between scattering parameter and coupling attenuation
- to include the 20 dB envelope curve:

#### Rationale:

In the triaxial cell method the formula to convert from measured voltage ratio to coupling attenuation is not always correctly applied (see IEC TC 46/WG5: Web\_201030\_02). The formula will therefore be extended to the measured S-parameter.

To make test results comparable, an envelope curve is introduced, see figures 7 and 8.

Add, after Annex G, the following new Annex H

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## Annex H (normative)

# Coupling attenuation expressed by mixed mode scattering parameter and an envelope line

## H.1 General

Coupling attenuation is often measured with a multiport network analyser with mixed mode scattering parameters. In this case the formulae for the conversion from voltage ratio to the coupling attenuation shall be rearranged.

An envelope curve shall be drawn for the coupling attenuation. This simplifies the comparison of test results.

## H.1.1 Coupling attenuation expressed by mixed mode scattering parameter

The formula (195) is rearranged and expressed by a mixed mode scattering parameter.

$$a_{c} = -20\log_{10}\left|S_{sd21}\right| + 10\log_{10}\left|\frac{Z_{diff}}{Z_{0}}\right| + 10\log_{10}\left|\frac{2Z_{s}}{Z_{diff}}\right| = -20\log_{10}\left|S_{sd21}\right| + 10\log_{10}\left|\frac{2Z_{s}}{Z_{0}}\right|$$
(F.1)

where

a<sub>c</sub> is the coupling attenuation

S<sub>sd21</sub> is the forward transmission scattering parameter; DUT exited in differential mode; received power in single ended mode

Z<sub>diff</sub> is differential mode impedance g/standards/sist/632a9a65-40a8-4b4f-8060-

 $Z_s$  is the normalised value of the characteristic impedance of the environment of the cable;  $Z_s$ =150 $\Omega$ 

 $Z_0$  is the system impedance;  $Z_0=50\Omega$ 

## H.1.2 Envelope line of coupling attenuation

The coupling attenuation is expressed by a value A of an envelope line. The value A shall be deduced by drawing a curve derived from the following equation:

$$E_{\rm c} = \begin{cases} A \text{ if } 30\text{MHz} \le f < 100\text{MHz} \\ A - 20\log_{10}\left(\frac{f}{100}\right) \end{cases}$$
(F.2)

Where

f is the frequency in MHz

 $E_c$  is the envelop line of coupling attenuation in dB

A is the starting value of the envelope in dB

This curve shall be raised until the first peak of the measurement trace is intersected. The value A (in dB) is read where the curve intersects the Y axis, see.